

Notice of References Cited	Application/Control No.	Applicant(s)/Patent Under Reexamination	
	09/501,114	TZENG, YONHUA	
	Examiner Wesley D Markham	Art Unit 1762	Pag 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,451,260	09-1995	Versteeg et al.	118/725
	B	US-5,624,719	04-1997	Tanabe et al.	427/577
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 05-097583 A	04-1993	Japan	Semiconductor Energy Lab	-
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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